

SEARCHED			
Class	Sub.	Date	Exmr.
369	44.23 112.12 112.15 112.24 44.32 53.28	11/21/03	pus
369	44.32 44.23 53.28 112.12 112.15 112.24	5/14/04 ↓	pus

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	Date	Exmr.
aberration or aberration or aberration or aberration measure/measurement defects reflected split/splitter difference between signals focal shift thickness sensor PE Young provided Subclasses	11/21/03	fla
performed more extensive search using listed sub- classes. see attached EAST search in addition, also searched 44. 41 (arithmetic operation)	5/14/04	fla

INTERFERENCE SEARCHED			
Class	Sub.	Date	Exmr.

**BEST AVAILABLE COPY**